

<b>Search Notes</b> 	<b>Application/Control No.</b> 10/809,459	<b>Applicant(s)/Patent under Reexamination</b> TANAKA, YOSHIYUKI
<b>Examiner</b> Nam T. Nguyen	<b>Art Unit</b> 2824	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
365	63	8/1/2006	NN
365	185.09	8/1/2006	NN
365	201	8/1/2006	NN
365/195		8/1/2006	NN